



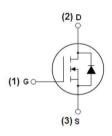
MJ N-Channel Enhancement Mode Power MOSFET

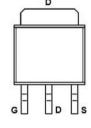
Description

The MJ6020I uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

- ♦ V_{DS} =60V,I_D =20A R_{DS(ON)} <44mΩ @ V_{GS}=10V
- ♦ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current
- ◆ Good stability and uniformity with high E_{AS}
- ◆ Excellent package for good heat dissipation
- ◆ Special process technology for high ESD capability





Application

◆ Power switching application

Uninterruptible power supply

Hard switched and high frequency circuits



Schematic diagram

Marking and pin assignment

TO-251 top view

100% UIS TESTED! 100% ΔVds TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ6020I	MJ6020I	TO-251	-	-	-

Absolute Maximum Ratings (Tc =25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	60	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	lo	20	А
Drain Current-Continuous(Tc =100°C)	I _D (100℃)	14	А
Pulsed Drain Current	Ідм	45	А
Maximum Power Dissipation	Po	30	W
Derating factor		0.2	W/°C
Single pulse avalanche energy (Note 5)	Eas	72	mJ
Operating Junction and Storage Temperature Range	Тл ,Тѕтс	-55 To 175	°C

Thermal Characteristic

Thermal Resistance,Junction-to-Case (Note 2)	Rөjc	5	°C/W	
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Electrical Characteristics (Tc =25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics				•		
Drain-Source Breakdown Voltage	BVoss	V _{GS} =0V I _D =250µA	60	-	-	V
Zero Gate Voltage Drain Current	IDSS	V _{DS} =60V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	Igss	V _{DS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250μA	1.2	2.0	2.5	V
Drain-Source On-State Resistance	Rds(ON)	V _{GS} =10V, I _D =10A	-	37	44	mΩ
Forward Transconductance	grs	V _{DS} =5V,I _D =4.5A	11	-	-	S
Dynamic Characteristics (Note 4)						
Input Capacitance	Ciss		-	500	-	PF
Output Capacitance	Coss	V _{DS} =30V,V _{GS} =0V F=1.0MHz	-	60	-	PF
Reverse Transfer Capacitance	Crss		-	25	-	PF
Switching Characteristics (Note 4)						,
Turn-on Delay Time	td(on)		-	5	-	nS
Turn-on Rise Time	tr	V _{DD} =30V,I _D =2A,R _L =6.7Ω	-	2.6	-	nS
Turn-Off Delay Time	t _{d(off)}	V _{GS} =10V,R _G =3Ω	-	16.1	-	nS
Turn-Off Fall Time	tf		-	2.3	-	nS
Total Gate Charge	Qg		-	14	-	nC
Gate-Source Charge	Qgs	V _{DS} =30V,I _D =4.5A V _{GS} =10V	-	2.9	-	nC
Gate-Drain Charge	Q _{gd}		-	5.2	-	nC
Drain-Source Diode Characteristics						<u>l</u>
Diode Forward Voltage (Note 3)	VsD	V _{GS} =0V,I _S =20A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	20	А
	4		_	35	-	nS
Reverse Recovery Time	trr	T =25°C I=−20Λ				
Reverse Recovery Time Reverse Recovery Charge	Qrr	TJ=25°C, IF=20A di/dt=100A/µs ^(Note 3)	-	53	-	nC

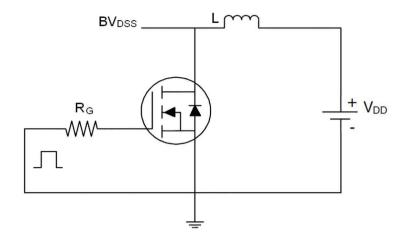
Notes:

- $\textcircled{1} \ \mathsf{Repetitive} \ \mathsf{Rating:} \ \mathsf{Pulse} \ \mathsf{width} \ \mathsf{limited} \ \mathsf{by} \ \mathsf{maximum} \ \mathsf{junction} \ \mathsf{temperature}.$
- ② Surface Mounted on FR4 Board, $t \le 10$ sec.
- ③ Pulse Test: Pulse Width ≤ 300 μ s, Duty Cycle ≤ 2%.
- 4 Guaranteed by design, not subject to production
- \bigcirc EAS condition:T_j=25°C,V_{DD}=30V,V_G=10V,L=0.5mH,Rg=25 Ω

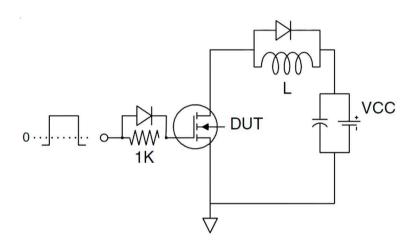




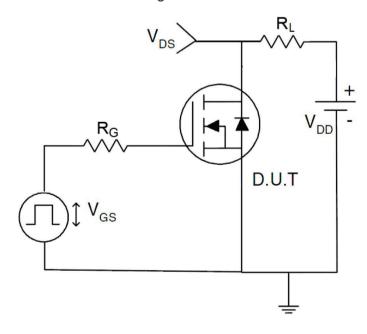
Test circuit



Eas test Circuit



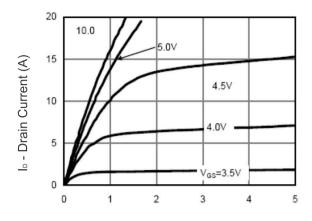
Gate charge test Circuit



Switch Time Test Circuit

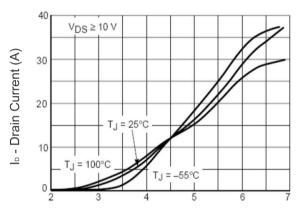


Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V)

Figure 1 Output Characteristics



Vgs Gate-Source Voltage (V)

Figure 2 Transfer Characteristics

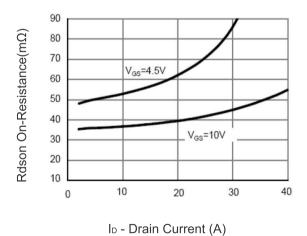
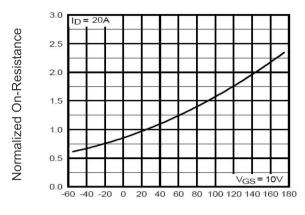


Figure 3 Rdson- Drain Current



T_J -Junction Temperature(°C)

Figure 4 Rdson-Junction Temperature

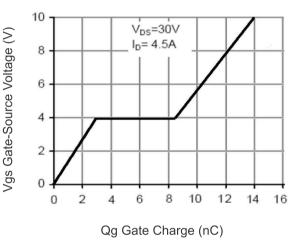
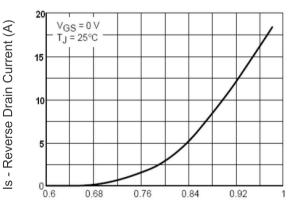


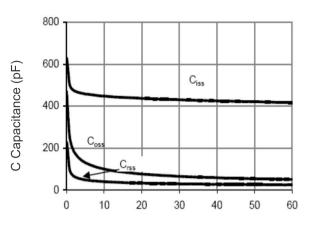
Figure 5 Gate Charge



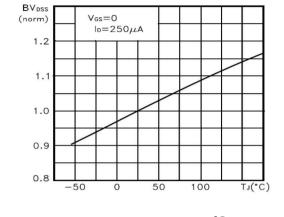
Vsd Source-Drain Voltage (V)

Figure 6 Source- Drain Diode Forward



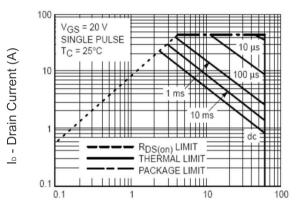


Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds

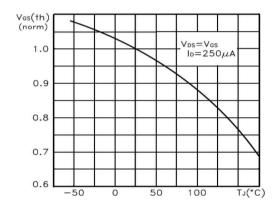


T_J -Junction Temperature(°C)

Figure 9 BV_{DSS} vs Junction Temperature



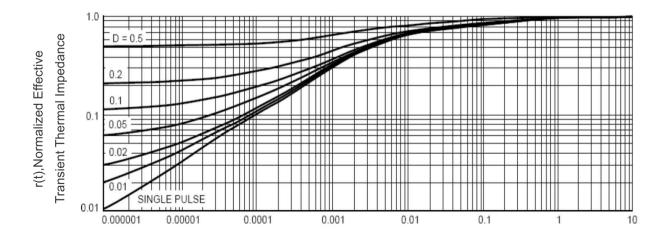
Vds Drain-Source Voltage (V)



T_J -Junction Temperature(°C)

Figure 10 V_{GS(th)} vs Junction Temperature





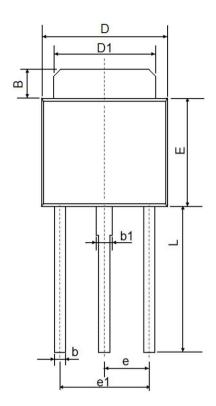
Square Wave Pluse Duration(sec)

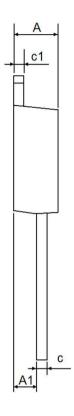
Figure 11 Normalized Maximum Transient Thermal Impedance





TO-251 Package Information





Symah al	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
А	2.200	2.400	0.087	0.094
A1	1.050	1.350	0.042	0.054
В	1.350	1.650	0.053	0.065
b	0.500	0.700	0.020	0.028
b1	0.700	0.900	0.028	0.035
С	0.430	0.580	0.017	0.023
c1	0.430	0.580	0.017	0.023
D	6.350	6.650	0.250	0.262
D1	5.200	5.400	0.205	0.213
E	5.400	5.700	0.213	0.224
е	2.300	TYP	0.091	TYP
e1	4.500	4.700	0.177	0.185
L	7.500	7.900	0.295	0.311





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